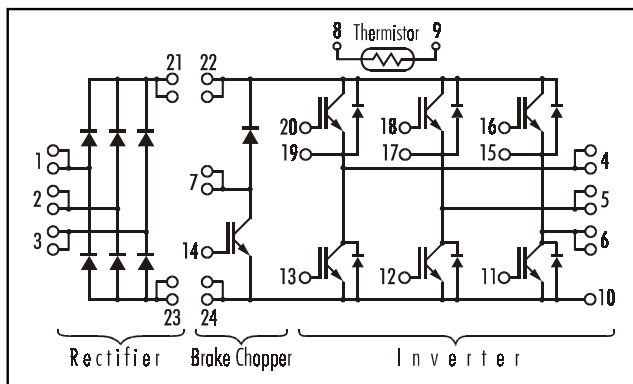


Power Integrated Module (PIM)

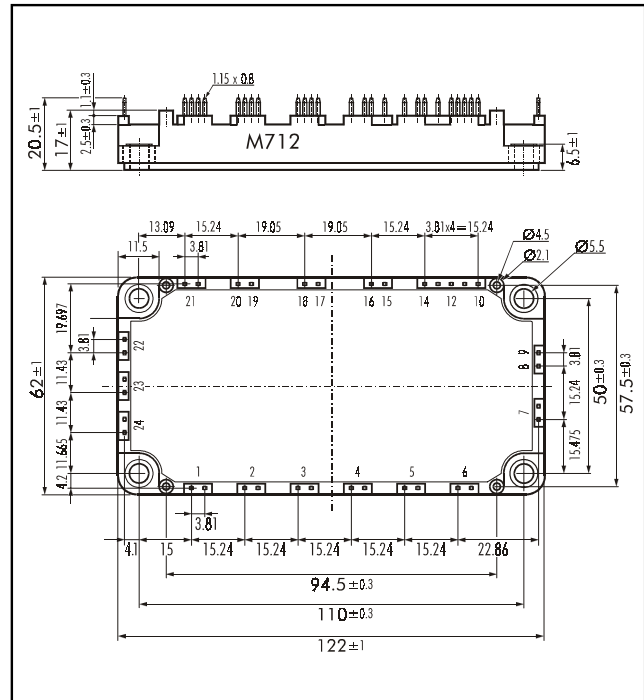
■ Features

- NPT-Technology
- Solderable Package
- Square SC SOA at $10 \times I_C$
- High Short Circuit Withstand-Capability
- Small Temperature Dependence of the Turn-Off Switching Loss
- Low Losses And Soft Switching

■ Equivalent Circuit



■ Outline Drawing



■ Absolute Maximum Ratings ($T_c=25^\circ\text{C}$)

	Items	Symbols	Test Conditions		Ratings	Units
Inverter	Collector-Emitter Voltage	V_{CES}			1200	V
	Gate -Emitter Voltage	V_{GES}			± 20	
	Collector Current	I_C	Continuous	25°C / 80°C	75 / 50	A
				1ms	25°C / 80°C	
			$-I_C$ PULSE			
Collector Power Dissipation	P_C	1 device		360	W	
Rectifier	Repetitive Peak Reverse Voltage	V_{RRM}			1600	V
	Average Output Current	I_O	50Hz/60Hz sinus wave		50	A
	Surge Current (Non Repetitive)	I_{FSM}	$T_j=150^\circ\text{C}$, 10 ms, sinus wave		520	
	I^2t (Non Repetitive)				1352	A^2s
Brake Chopper	Collector-Emitter Voltage	V_{CES}			1200	V
	Gate -Emitter Voltage	V_{GES}			± 20	
	Collector Current	I_C	Continuous	25°C / 80°C	35 / 25	A
			1ms	25°C / 80°C	70 / 50	
	Collector Power Dissipation	P_C	1 device		180	W
Repetitive Peak Reverse Voltage	V_{RRM}			1200	V	
Operating Junction Temperature	T_j			+150	°C	
Storage Temperature	T_{Stg}			-40 ~ +125		
Isolation Voltage	V_{ISO}	A.C. 1min.		2500	V	
Mounting Screw Torque*				3.5	Nm	

Note: *:Recommendable Value; 2.5 ~ 3.5 Nm (M5)

■ Electrical Characteristics (T_J=25°C)

Items		Symbols	Test Conditions	Min.	Typ.	Max.	Units	
Inverter	IGBT	Zero Gate Voltage Collector Current	I _{CES}	V _{GE} =0V V _{CE} =1200V			1.0	mA
		Gate-Emitter Leakage Current	I _{GES}	V _{CE} =0V V _{GE} =± 20V			200	nA
		Gate-Emitter Threshold Voltage	V _{GE(th)}	V _{GE} =20V I _C =50mA	5.5	7.2	8.5	
		Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} =15V I _C = 50A	Chip	2.1		V
		Input Capacitance	C _{ies}	f=1MHz, V _{GE} =0V, V _{CE} =10V		6000		pF
	Turn-on Time	t _{on}	V _{CC} = 600V I _C = 50A		0.35	1.2		
		t _{r,x}	V _{GE} = ±15V		0.25	0.6		
		t _{r,i}	R _G = 24Ω		0.45	1.0		
		t _{off}	Inductive Load		0.08	0.3		
		t _f						
FRD	Diode Forward On-Voltage	V _F	I _F =50A	Chip	2.3		V	
	Reverse Recovery Time	t _{rr}	I _F =50A	Terminal	2.5	3.3	ns	
Rectifier	Forward Voltage	V _{FM}	I _F =50A	Chip	1.1		V	
	Reverse Current	I _{RRM}	V _R =1600V	Terminal	1.2	1.5	mA	
Brake Chopper	Zero Gate Voltage Collector Current	I _{CES}	V _{GE} =0V V _{CE} =1200V			1.0	mA	
	Gate-Emitter Leakage Current	I _{GES}	V _{CE} =0V V _{GE} =± 20V			200	nA	
	Collector-Emitter Saturation Voltage	V _{CE(sat)}	V _{GE} =15V I _C =50A	Chip	2.10		V	
				Terminal	2.25	2.7		
	Turn-on Time	t _{on}	V _{CC} = 600V I _C = 15A		0.35	1.2		
		t _{r,x}	V _{GE} = ±15V		0.25	0.6	μs	
		t _{r,i}	R _G = 51Ω		0.45	1.0		
Turn-off Time	t _{off}			0.08	0.3			
	t _f							
Reverse Current	I _{RRM}	V _R =1200V			1.0	mA		
NTC	Resistance	R	T= 25°C		5000		Ω	
			T=100°C	465	495	520		
	B Value	B	T=25 / 50°C	3305	3375	3450	K	

■ Thermal Characteristics

Items	Symbols	Test Conditions	Min.	Typ.	Max.	Units
Thermal Resistance (1 device)	R _{th(j-c)}	Inverter IGBT			0.35	°C/W
		Inverter FRD			0.75	
		Brake IGBT			0.69	
		Rectifier Diode			0.50	
Contact Thermal Resistance	R _{th(c-f)}	With Thermal Compound		0.05		

